



**MBH**

# **Quench and degradation locations.**

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TE-MS-C-TF

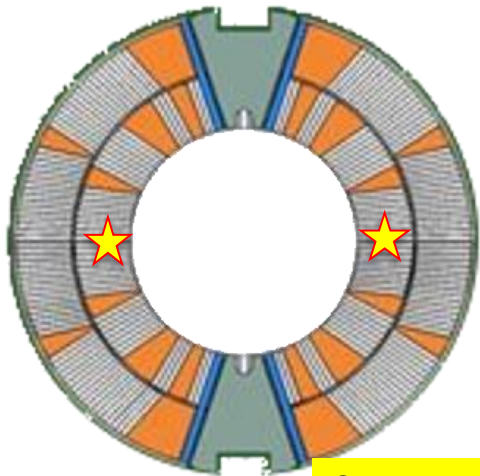
**10-07-2020**



# Degradation issues MBH models, proto and series

## Midplane, straight segment issues

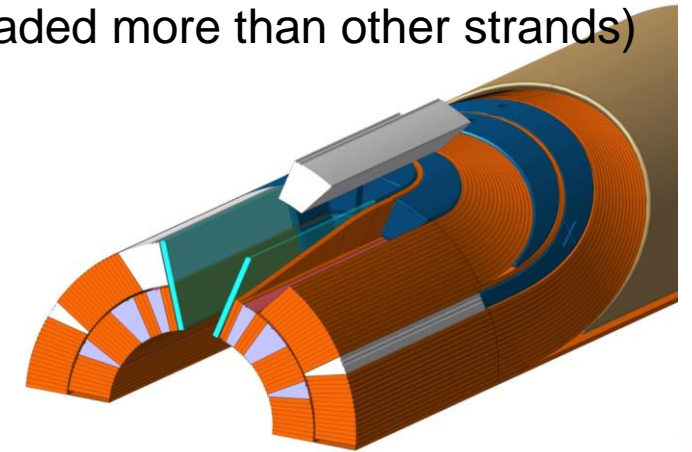
- Problem for many model magnets
- Inner layer Midplane
- Straight part
- “Homogeneous” cable degradation
- Solved !?!?!?
- 2D problem?? Only cross-section??



Only seen in model magnet (but hybrid at 4.5 K confirmed that the upper limit at 12.7 kA was in the midplane  $I/I_{ss} = 94\%$ ).

## Head/pole turn issues

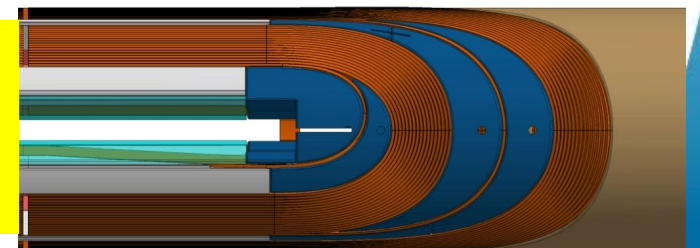
- 2 times in model magnets, 5 times in long magnets
- Head or transition region of the magnet, possibly pole turns inner layer.
- In 3 cases after thermal cycle connection side
- “non-Homogeneous” cable degradation (one or more strands degraded more than other strands)
- Un-solved
- 3D problem.



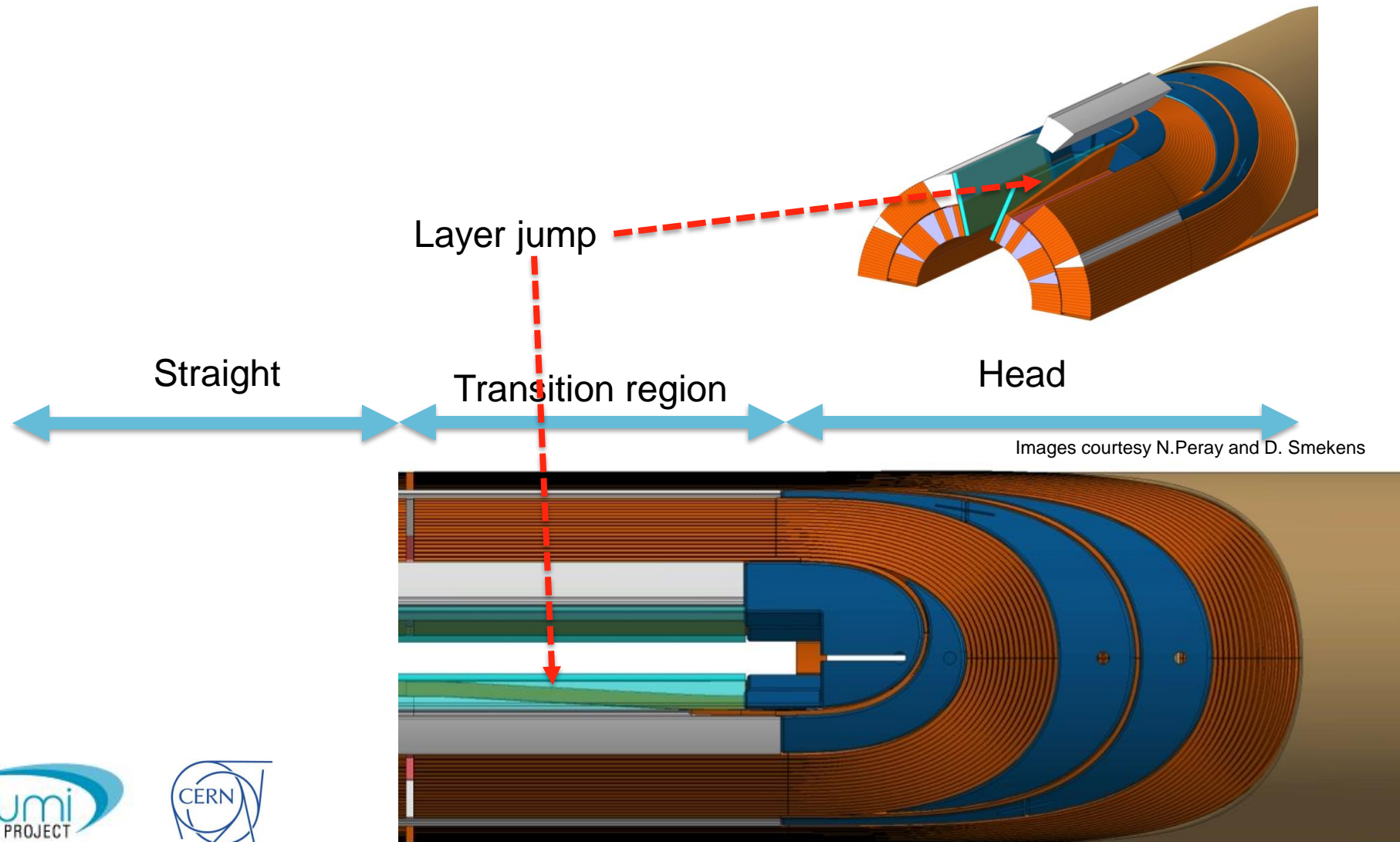
Images courtesy N.Peray and D. Smekens

In two model coils there was also a pole turn/layer jump issue.

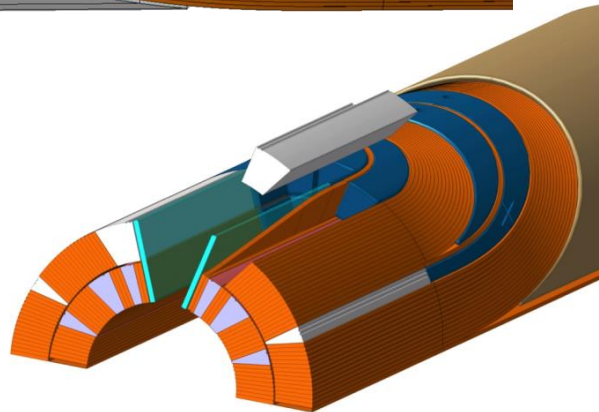
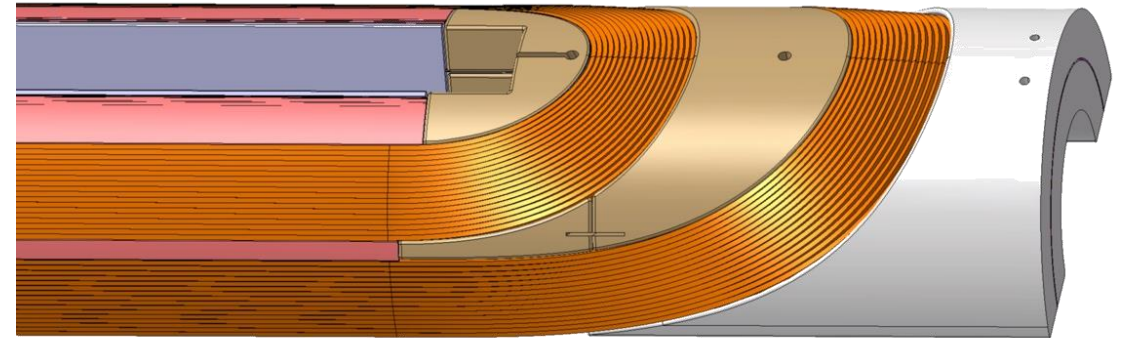
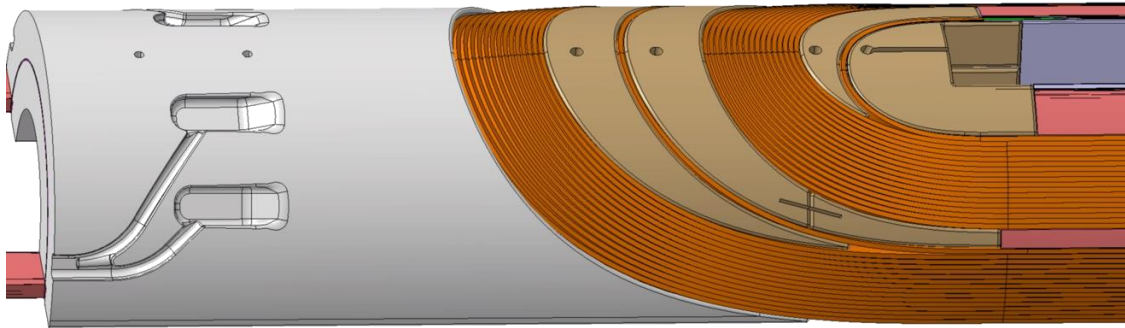
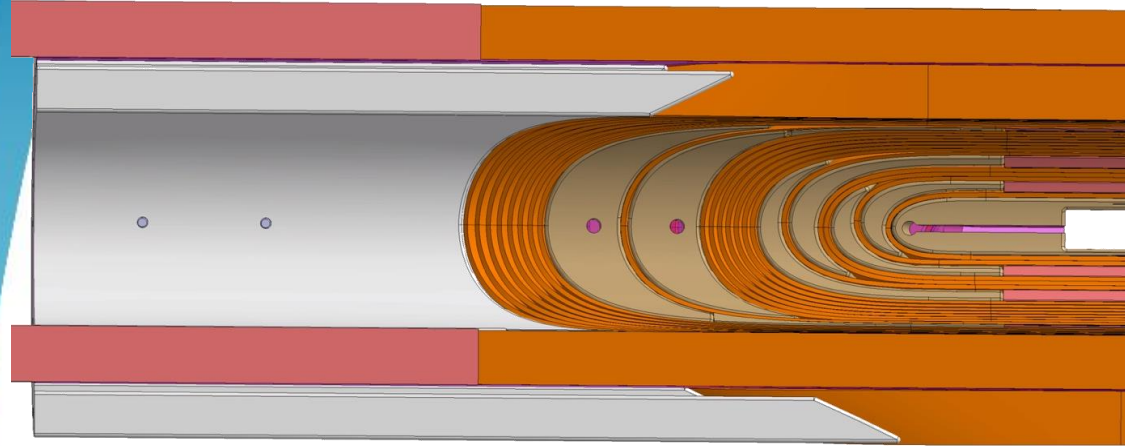
In these slide I do not look at the mid-plane issues.



# Nomenclature

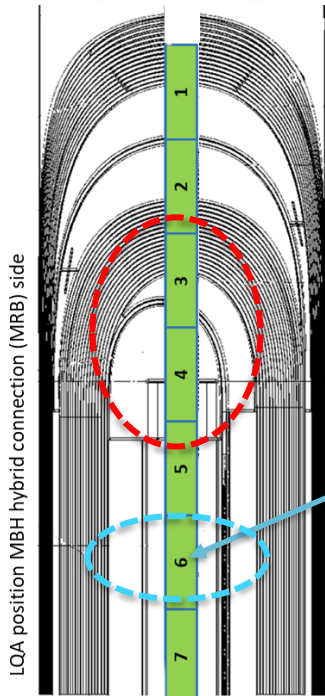
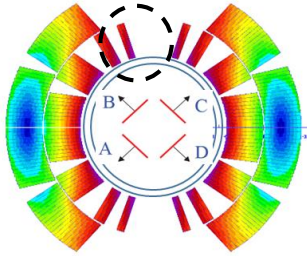


# Images

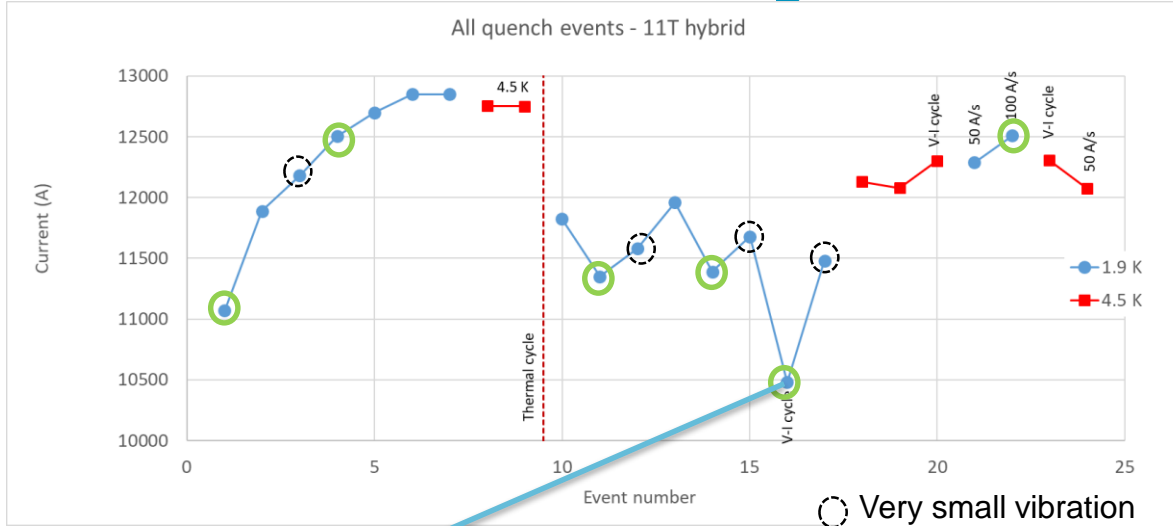


There is no absolute certainty from the data if a quench occurs in the outer layer or inner layer for a series magnet.  
In the ext slides an image of the outer layer is used: this could be misleading.

# MBH-hybrid D1U

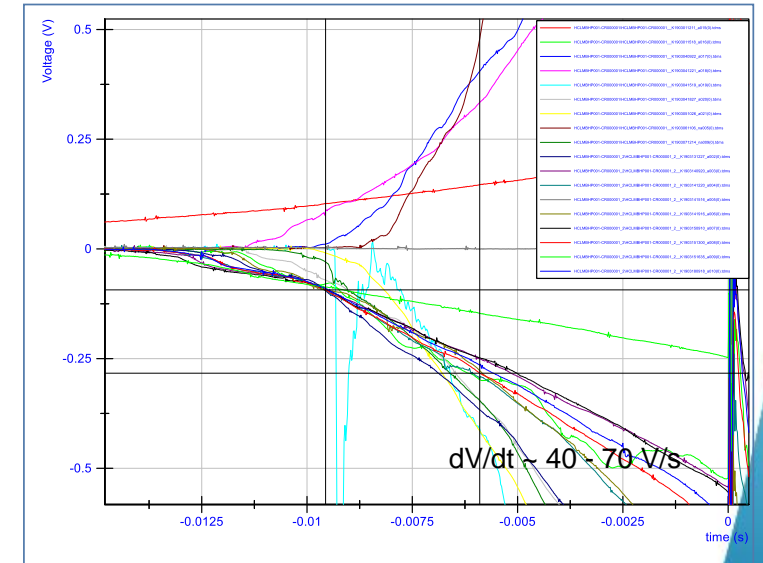
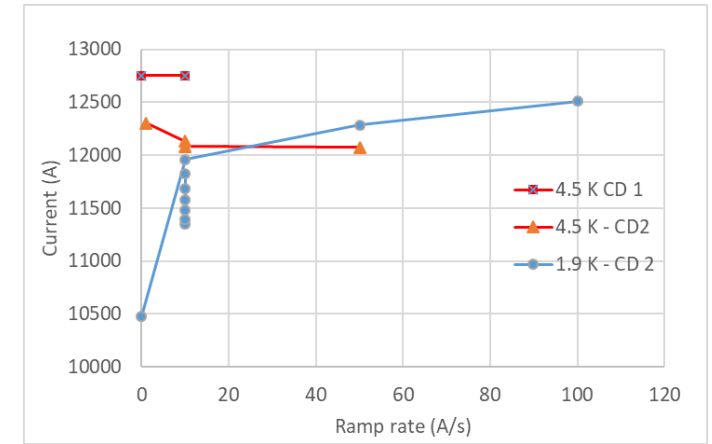


LQA position MBH hybrid connection (MRB) side



○ Very small vibration  
○ Larger vibration

- No quenches in CD 1
- All quenches, but 1, starting in segment 3-4, some with and some without precursor.
- 1 quench (lowest current, V-I cycle) started around segment 6.



# Quench Location vs Defect Location

## Is the quench location identical to the defect location??

- Some quenches start with external energy source (precursor), other quenches start without (measurable) precursor.
- Some quenches (particularly at 1.9 K) may be caused by instabilities.
- Some quenches (particularly at 4.5 K) may be caused by reaching the critical surface (B, T, J)

## Non-homogeneous defects (affecting one or a few strands)

Modeling done on defects in one or a few strands (Ruben Keijzer, Giovanni Succi):

- The strand with defect will carry almost 0 current. This strand may be very difficult to quench!!!
- Neighbouring strands will carry most current, not only around the defect, but also throughout most of the coil!!! These strands may be easily quenched, since they are pushed towards carrying their critical current and possibly closer to instability limits.

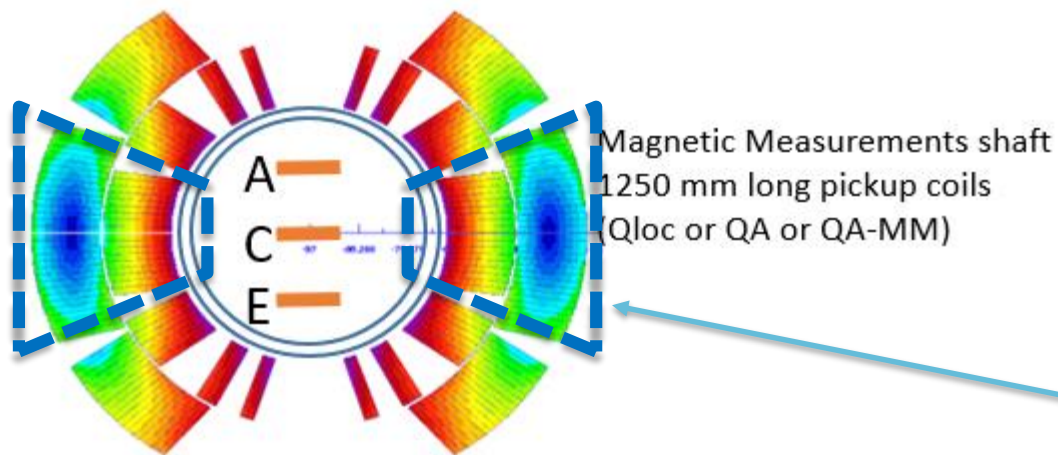
Some 'weak' consensus of phenomenology:

**Fast ramps:** Current pushed more through the defect, main redistribution directly around defect (could still be meters)

**Slow ramps/plateaus:** Time to redistribute over long lengths, up to the splices.

Time constant for redistribution strongly varies over the distribution length (seconds to minutes)

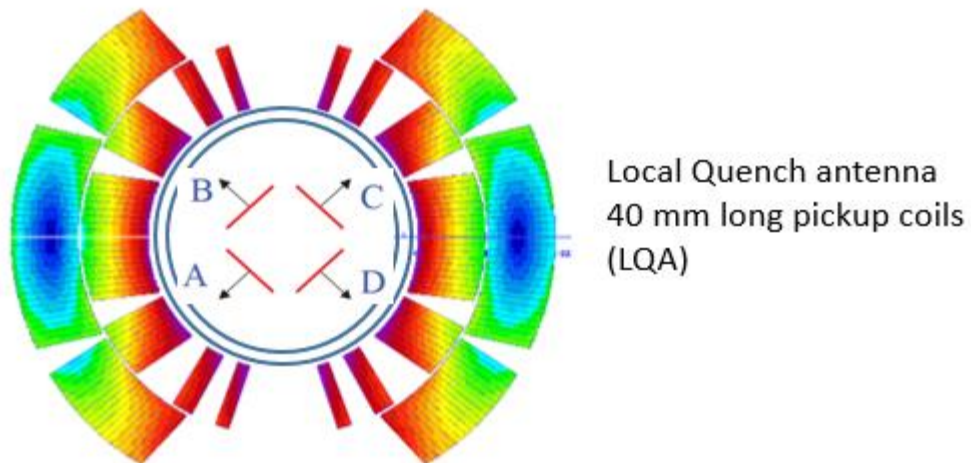
# Exclusion midplane blocks



Two Quench Localisation shafts:

The data from the first shaft (long pickup coils) show that in all quenches there is only a signal in either A or E.

This means we can effectively **exclude the midplane blocks** from the investigation.



The data from the second shaft (short pickup coils, 4 cm long) gives the longitudinal position very precisely.

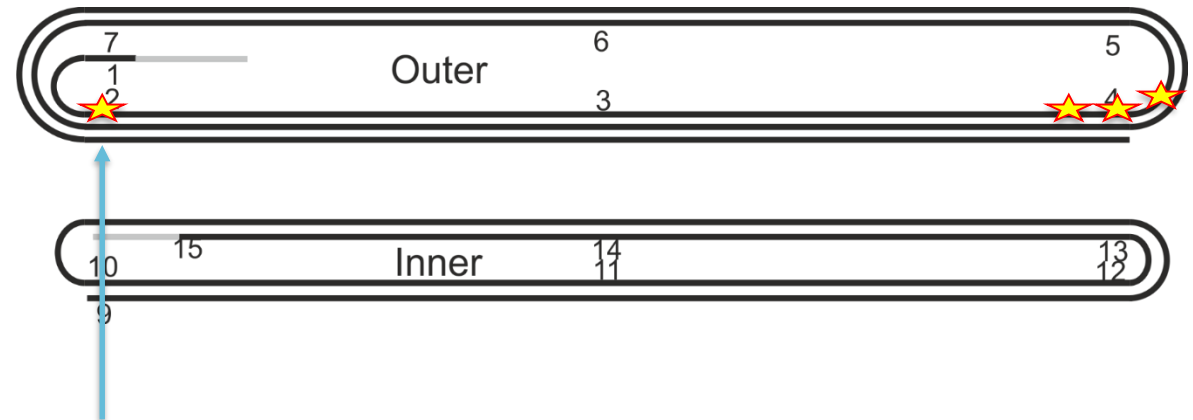
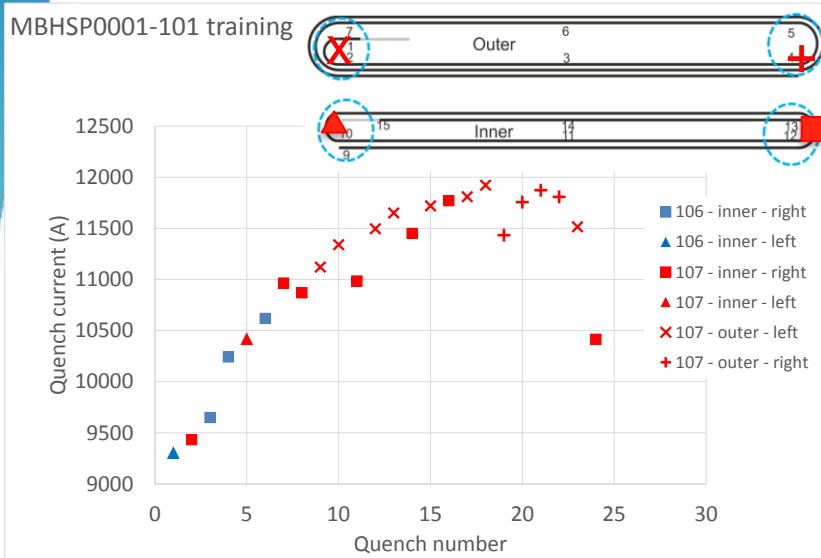
We still debate how precise we can find the azimuthal quench start location.

# Overview table of degradation issues in coils

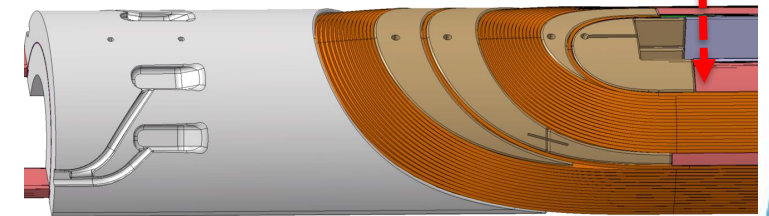
Magnet	Cryo process	Degradation
MBHSP101 (coil 107)	Long test station	CD 1: Coil 107, outer layer quenches
MBHSP104 (coil 113)	Long test station	CD 1: Coil 113, slow training, layer jump quenches.
MBH-Prototype	No delta T specifications (fast cool down)	CD 1: D2U, head, connection side and non-connection side
MBH-hybrid (1 aperture)	No delta T specifications (fast cool down and warm up)	CD 1: OK up to 12.85 kA at 1.9 K, 12.6 kA at 4.5 K CD 2: D1U, head connection side
MBHB-002	Delta T = 30 K for range 90 K – 300 K	CD 1: - CD 2: -
MBHA-001	Delta T = 30 K for range 90 K – 300 K	CD 1: no data above 9 kA CD 2: no degradation up to 11.95 kA at 1.9 and 4.5 K. CD 3: D2L, head, connection side. small degradation D1L, head connection side noticeable. CD 4: D2L, head, connection side (same as CD 3) D1L, head connection side strongly degraded.
MBHA-002	Delta T = 30 K for range 90 K – 300 K	CD 1: D1U, Head, Non-connection side.



# First short model: MBHSP101 – coil 107



Opposite of the layer jump.



Quenches in both Connection side and non-connection side in the head of coil 117. Mainly in the outer layer!!

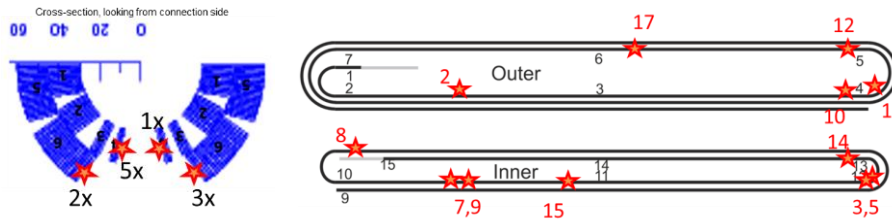
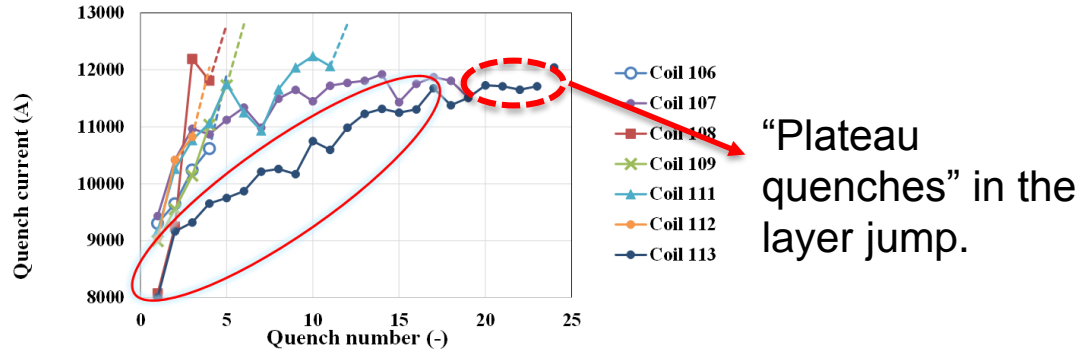
No quench antenna data.

## Characteristics

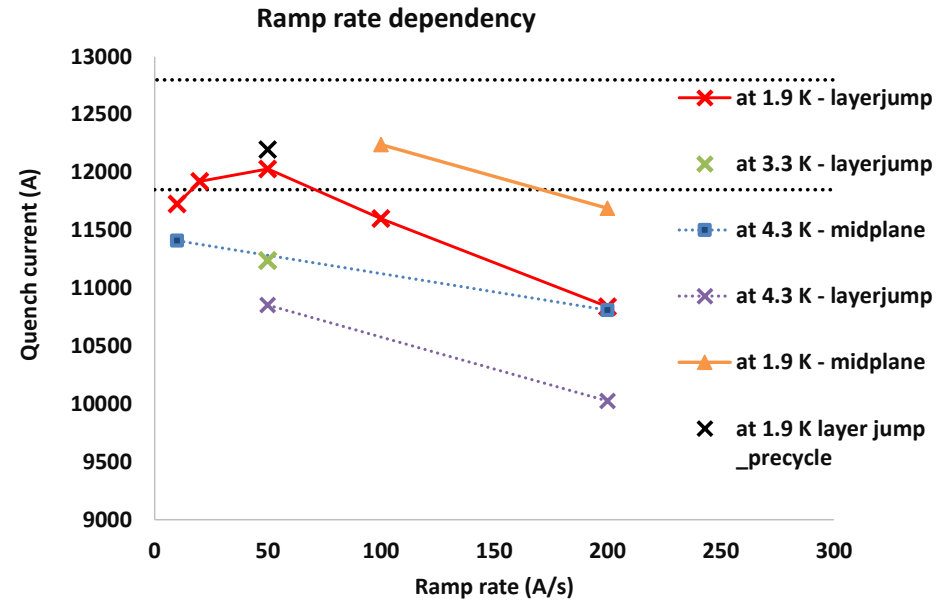
Outer layer quenches, pole turn.

Around voltage tap location and transition region.

# MBHSP104 – coil 113



Very slow training throughout pole turn inner and outer layer.

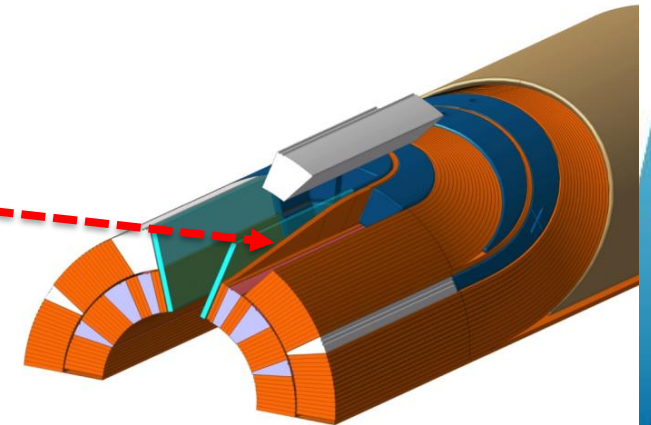


For some temperature/ramp rate, the limit is in the layer jump, others are in the midplane.

## Characteristics

- Very slow training throughout pole turns.
- Limiting quenches in the layer jump.
- Very fast quench propagation
- Strange temperature characteristics.

Clear case of non-homogeneous conductor degradation.



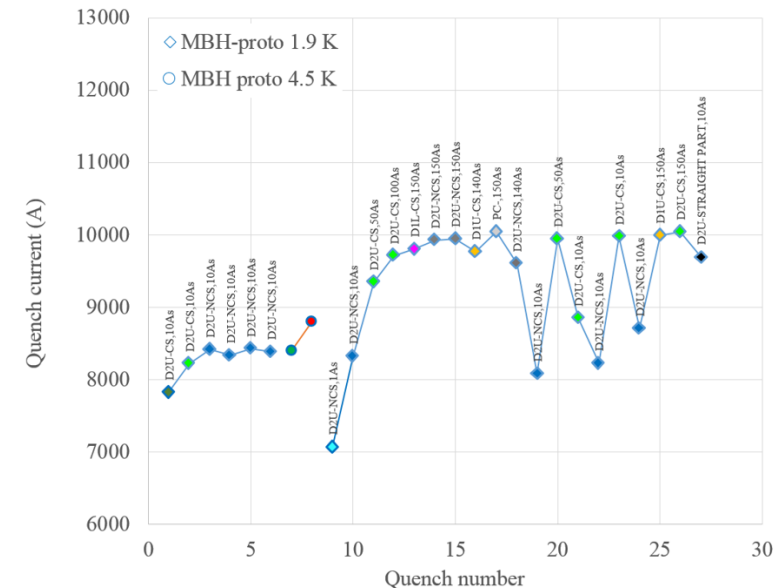
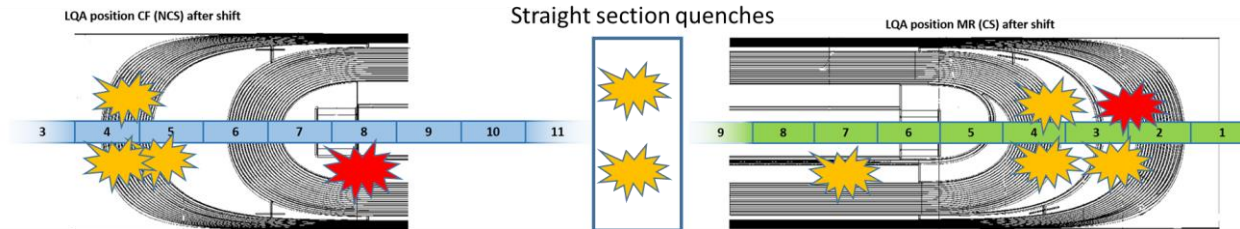
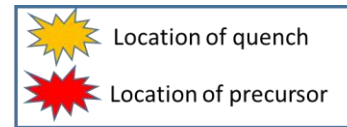
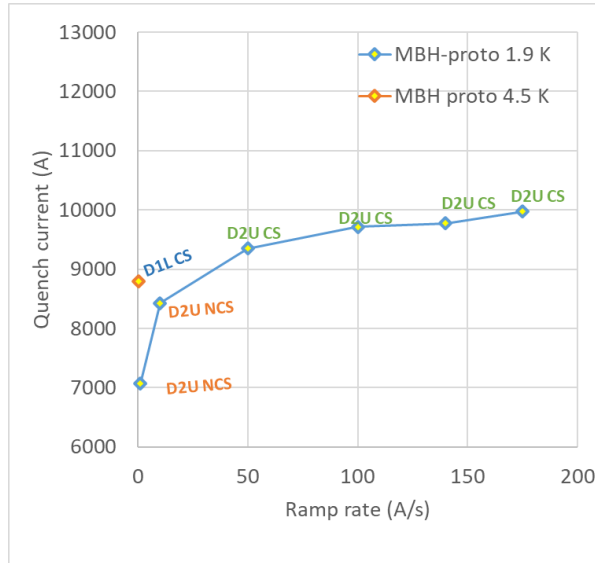
# MBH-proto D2U

## Characteristics

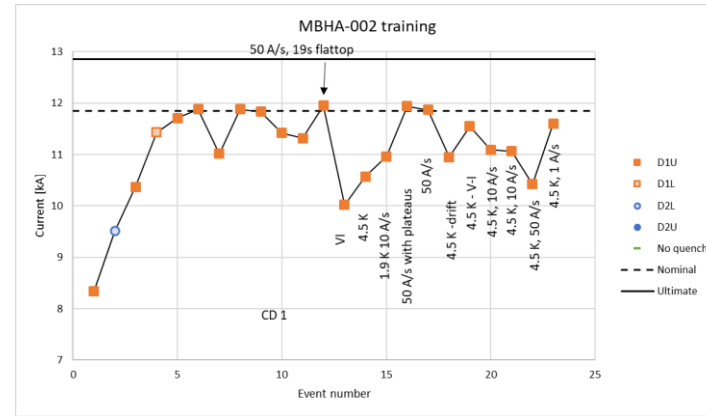
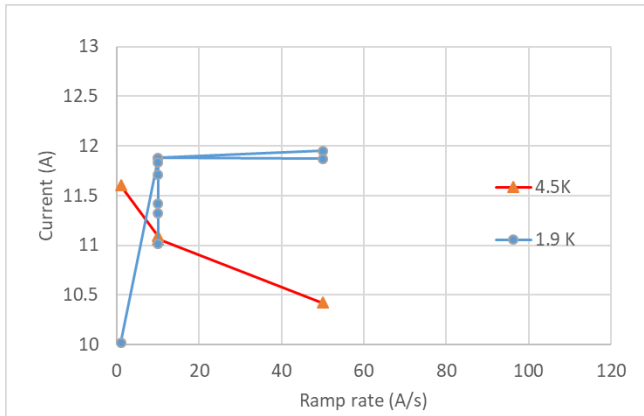
Very strong degradation, high voltage measured in V-I measurements.  
 Very fast quench propagation  
 Abnormal temperature characteristics.

## Difficulty:

Depending on ramp rate quenches occur in both heads:  
 - Or 2 separate defects, or is there one defect that causes current redistribution over long lengths to render the coil instable in both heads?



# MBHA-002 – D1U



## Characteristics

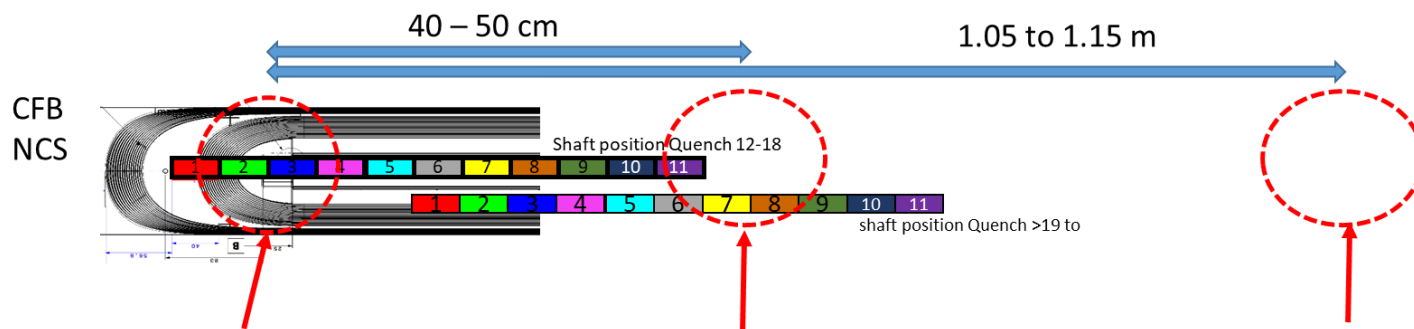
Abnormal ramp rate dependency  
Clear decay in V-I measurements  
Connectoin si

## Difficulty:

3 quench locations, depending on the temperature and ramp rate.

## Consensus:

- The most likely to quench at the defect location is when: at 4.5 K and ramping fast. In this case that would be in the head, non-connection side.



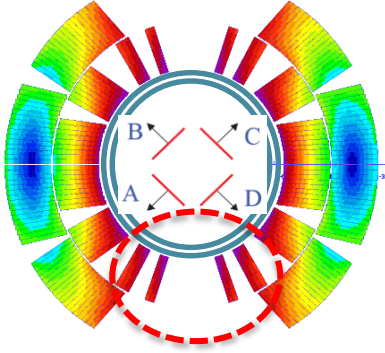
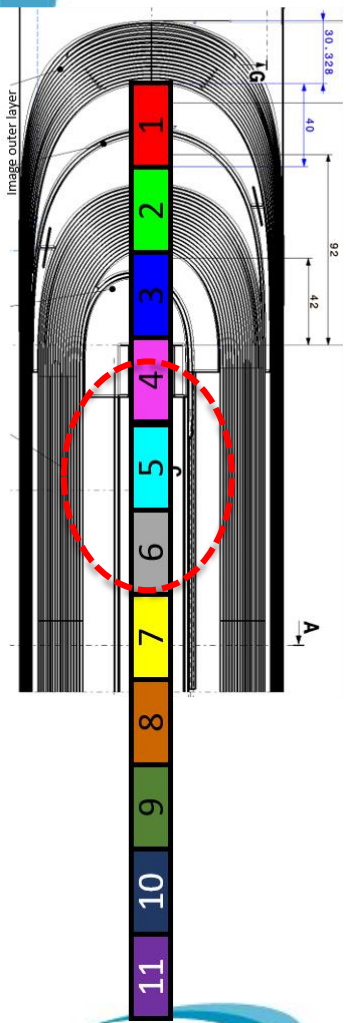
1.9 K, 10 A/s – all quenches  
1.9 K, 50 A/s+ 19seconds plateau  
1.9 K V-I cycle  
4.5 K, 10 A/s – 2 quenches  
4.5 K, 50 A/s

1.9 K, 50 A/s  
4.5 K after drift from 1.9 k (2 times)

4.5 K V-I cycle  
4.5 K 1A/s ramp (special cycle)

# MBHA-001, D2L

MRB  
CS

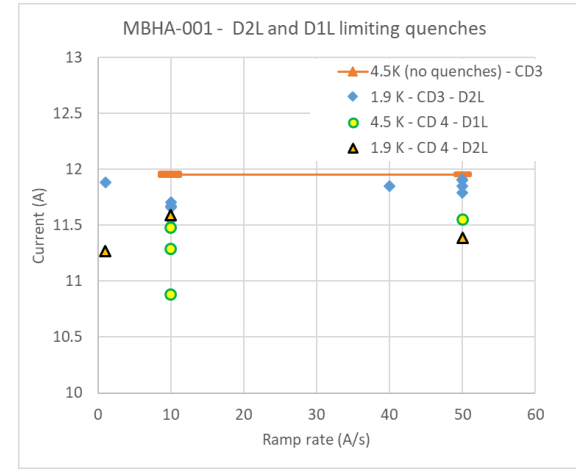


## Characteristics

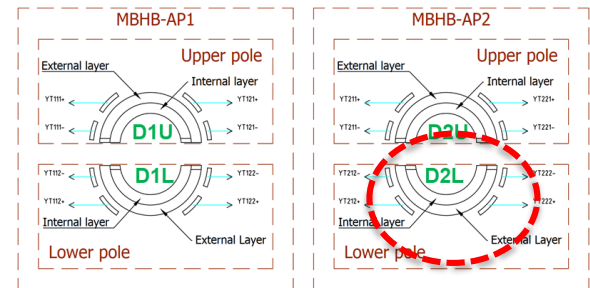
- Only apparent degradation in Cool Down 3
- Clear decay in V-I measurements
- Abnormal temperature and ramp rate dependency.

## Quench location

- Connection side
- Transition region. Could be layer jump.

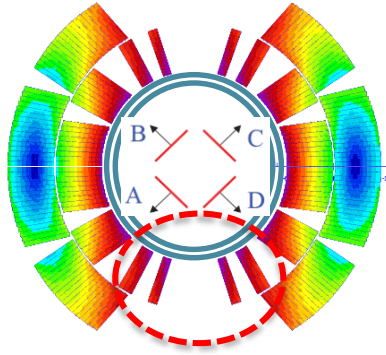
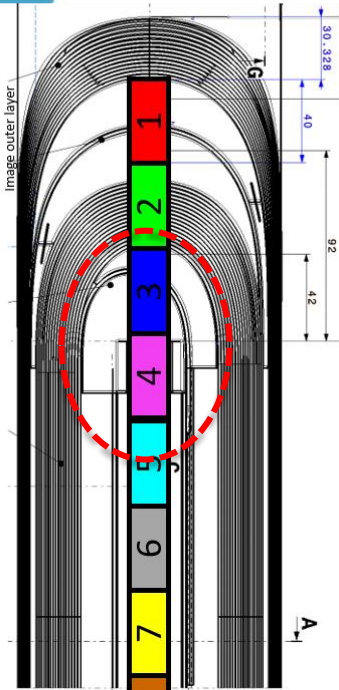


$dV/dt \sim 50 \text{ V/s}$



# MBHA-001 - D1L

MRB  
CS



## Characteristics

Main degradation in Cool Down 4

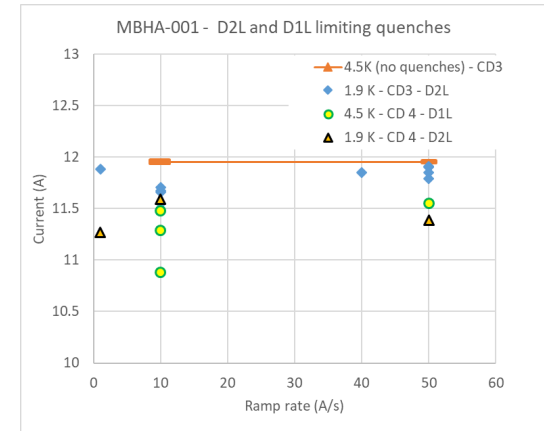
Clear decay in V-I measurements

Abnormal temperature and ramp rate dependency.

## Quench location

Connection side

Head, possibly towards transition region.



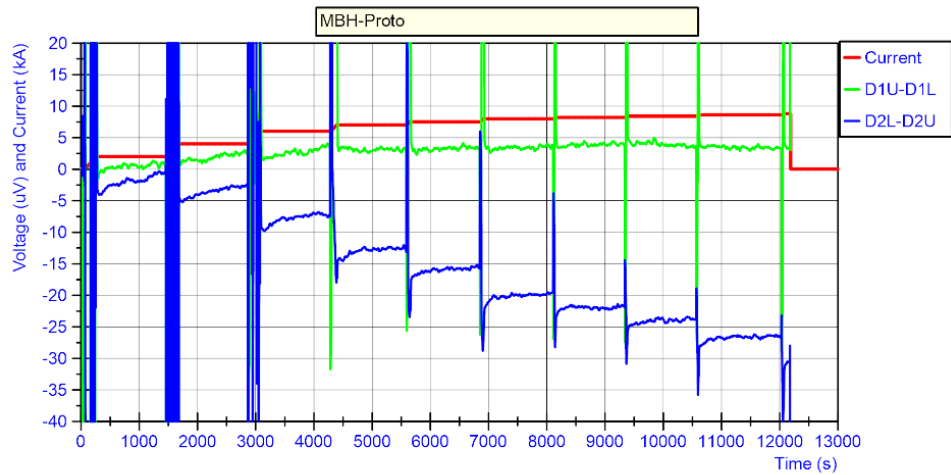
# Characteristics of quenches

Magnet	$I_{c 1.9}/I_{c 4.5}$ (1 A/s)*	Quench location	dV/dt [V/s]	Feature in early quench voltage (< 5 ms)	Ramp rate dependency	Suspected damage type
MBHSP101 (coil 107)		Heads/outer layer				
MBHSP104 (coil 113)	1.03	Heads/straight section	150-300		Reversed** below 50 A/s @1.9 K	Local
MBH-prototype	0.87	head	40	yes	Reversed @1.9 K	
MBH-hybrid	0.85	head	40-70	yes	Reversed @1.9 K	Local
MBHA-002	0.86	Head/straight section	100	yes	Reversed @1.9 K	Local
MBHA-001	0.95 (CD3/CD4)	Head	50-100	Yes (D1L)	Reversed @1.9/4.5 K	Local (progressive)

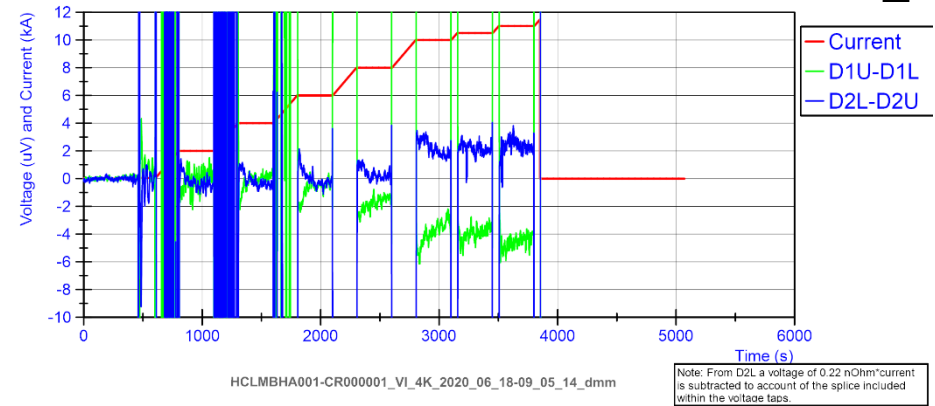
DRAFT table, to be expanded and made more precise

# V-I curves

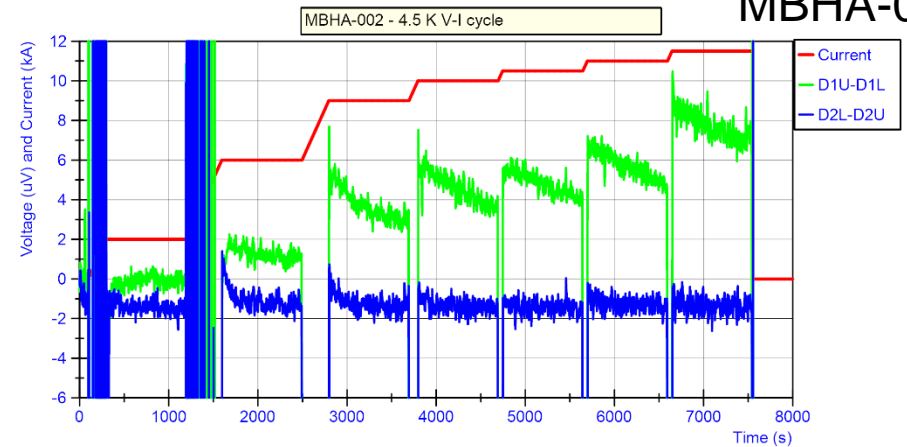
MBH-Prototype\_CD4\_4.5 K



MBHA-001\_CD4\_4.5 K

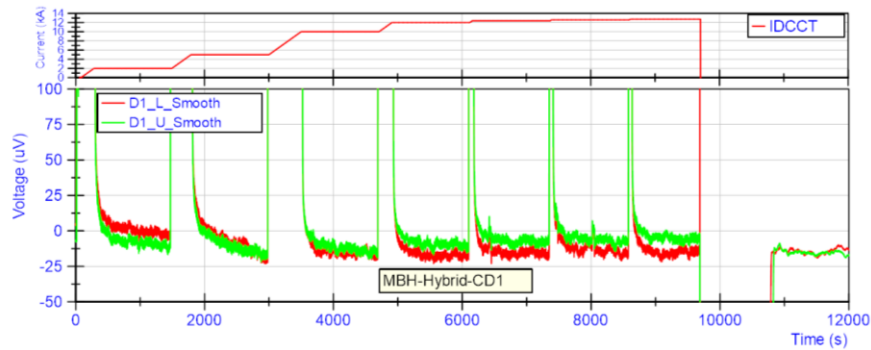


MBHA-002\_4.5 K



## MBH-hybrid data

(slightly different measurement settings)





# Overview table of degradation issues in coils

	Head/straight	Upper/lower coil	Aperture 1/2	Connection/non-connection side	First notification of degradation	CD/WU process
MBHSP101	Head	Coil 107		CS and NCS	CD1	Long test station (Lhe)
MBHSP104	Head	Coil 113		CS	CD1	Long test station (Lhe)
MBH-proto	Head	Upper	2	CS and NCS	CD 1	Fast
MBH-hybrid	Head	Upper	1	CS	CD 2	Fast
MBHA-001 defect 1	Head	Lower	2	CS	CD 3	$\Delta T = 30 \text{ K (90 K - 300 K)}$ $\Delta T = 80 \text{ K (4 K - 90 K)}$
MBHA-001 defect 2	Head	Lower	1	CS	CD 4	$\Delta T = 30 \text{ K (90 K - 300 K)}$ $\Delta T = 80 \text{ K (4 K - 90 K)}$
MBHB-002	Head	Upper	1	NCS	CD 1	$\Delta T = 30 \text{ K (90 K - 300 K)}$ $\Delta T = 80 \text{ K (4 K - 90 K)}$